

Notice of References Cited	Application/Control No. 10/753,492	Applicant(s)/Patent Under Reexamination CHEN ET AL	
	Examiner Janet M. Wilkens	Art Unit 3637	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,788,348	08-1998	Ramachandran et al.	312/223.1
	B	US-6,338,182	01-2002	Tseng et al.	16/386
	C	US-5,604,337	02-1997	Sugimoto et al.	181/152
	D	US-6,370,037	04-2002	Schoenfish, Brian G.	361/807
	E	US-D439,225	03-2001	Kita, Toshiyuki	D14/126
	F	US-6,802,575	10-2004	Lee, Harry P.	312/7.2
	G	US-D483,020	12-2003	Nagao et al.	D14/126
	H	US-D483,726	12-2003	Teng et al.	D14/126
	I	US-D490,063	05-2004	Miller, John M.	D14/126
	J	US-6,480,243	11-2002	Yamamoto, Kouichi	348/836
	K	US-D499,387	12-2004	Liu et al.	D14/126
	L	US-6,494,429	12-2002	Tajima, Hisao	248/473
	M	US-6,688,576	02-2004	Oishi et al.	248/317

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Janet M. Wilkens

3/22/05